Se	arch	Notes	;

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/605,399	SHIUNG, DAVID	
Examiner	Art Unit	
Khanh Tran	2611	

SEARCHED			
Class	Subclass	Date	Examiner
375	271-272 278 295-297	2/11/2007	кст
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	307		
332	100		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH (INCLUDING SEAF		Y)
	DATE	EXMR
Searches EAST	2/11/2007	кст
Inventor Name Searches		